

PRODUCT SPECIFICATION

DOCUMENT NO.ENS000023130				
DESCRIPTION	DRAWN BY	DESIGNED BY	CHECKED BY	APPROVED BY
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RoHS Multilayer Power Inductor (MIP Series) Engineering Spec.

This product belongs to the industrial grade standard, not the vehicle gauge product! Can not use auto parts, if the customer is not expressly informed and privately used to auto parts, produce any consequences, the original is not responsible for after-sales service, thank you!

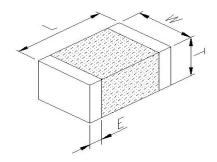
Features

- The monolithic construction performs high reliability and ensures a closed magnetic flux in a component avoids magnetic leakage and interference.
- Allow for higher mounting density.
- Low DC resistance.

Applications

Suitable for DVD, DSC, PND, PC, NB, Power Line

Shapes and Dimensions



TYPE	2012 (EIA0805)		
L	2.00±0.20		
W	1.25±0.20		
Т	0.90±0.10		
E	0.50±0.30		
Unit mm			

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■ Part Number Code

MIP 2012 2R2 M B E DG 1 2 3 4 5 6 7

1 Series Name

2 Size Code: The first two digitals: length(mm), the last two digitals: width(mm)

3 Inductance : R = Decimal point, Unit = μH

4 Tolerance : $M = \pm 20\%$

5 Soldering: Green Parts, B= Lead-Free for whole chip

6 Packaging: E = Embossed plastic tape, 7" reel

7 INPAQ internal code

■ Part Number and Characteristics Table

Part Number.	Inductance±20% (µH)	Test Freq. (MHz)	SRF (MHz)	DCR±25% (Ω)	Rated Current (mA)
MIP20122R2MBEDG	/	1	70	0.170	900
I Last Instruments and	●HP4291B-RF Impedance / Material Analyzer ●HP4338A/B Milliohm meter Test Frequency: 1 MHz / OSC Level: 100mV				

^{*1:} For special part number which is not shown in the above table, please refer to appendix.

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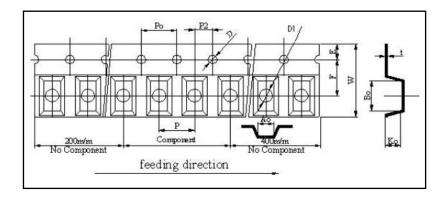
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^{*2 :} Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.



■ Tape and Reel Specifications

Plastic Carrier (E)



Taping Dimensions

(mm)	2012	
Symbol	E	
W	8.00 ± 0.10	
Р	4.00 ± 0.10	
Е	1.75 ± 0.10	
F	3.50 ± 0.10	
D	1.55 ± 0.05	
D1	1.00 ± 0.05	
Ро	4.00 ± 0.10	
10Po	40.0 ± 0.20	
P2	2.00 ± 0.10	
Ao	1.40 ± 0.10	
Во	2.30 ± 0.10	
Ko(T)	1.13 ± 0.10	
t	0.22 ± 0.05	

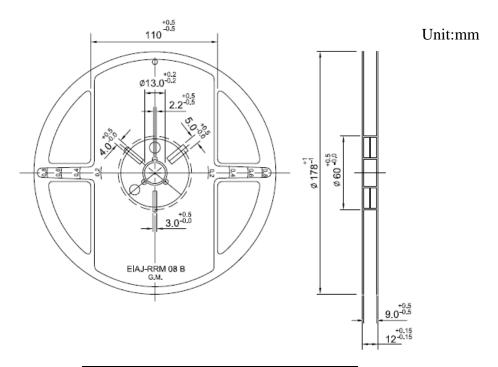
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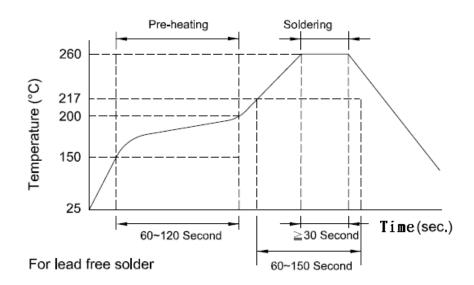


■ Reel Dimensions



7" Reel Packaging Quantity		
PART SIZE (EIA SIZE)	2012 (0805)	
Qty.(pcs)	3,000	
BOX	5 reels / inner box	

Recommended Soldering Conditions

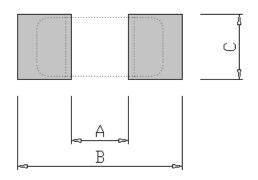


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■ Land Patterns for Reflow Soldering

Solder land information:



Size(mm)	Α	В	С
2012	1.0 ~ 1.2	3.0 ~ 4.0	0.8 ~ 1.1

■ Reliability and Test Condition

Test item	Test condition	Criteria
		More than 95 % of terminal electrode should be covered with new solder
Resistance to Solder Heat	 Solder temperature : 260 ± 5°C Flux : Rosin DIP time : 10 ± 1 sec 	 No mechanical damage Inductance value should be within ± 20 % of the initial value Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.
Solderability	 Solder temperature : 235 ± 5°C Flux : Rosin DIP time : 5 ± 1 sec 	More than 95 % of terminal electrode should be covered with new solder No mechanical damage

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Test item	Test condition	Criteria
Adhesive Test	 Reflow temperature : 245° ☐ It shall be Soldered on the substrate applying direction parallel to the substrate Apply force(F) : 5 N Test time : 10 sec 	No mechanical damage Soldering the products on PCB after the pulling test force > 5 N
Temperature Cycle	 Temperature:-40 ~ 85°C For 30 minutes each Cycle: 100 cycles Measurement:At ambient temperature 24 hours after test completion 	 No mechanical damage Inductance should be within ±20% of the initial value Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.
High Temperature Resistance	 Temperature: 85 ± 5°C Testing time: 1000 hrs Measurement: at ambient temperature 24 hours after test completion 	 No mechanical damage Inductance should be within ±20% of the initial value * Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.
Humidity	 Temperature: 40°C ± 2°C Humidity: 90-95 % RH Testing time: 1000 hrs Measurement:At ambient temperature 24 hours after test completion 	1. No mechanical damage 2. Inductance should be within ±20% of the initial value * Apply DC 0.4 ~ 0.6A to chip for 1 ~ 3 sec. before to measure inductance.
Rated Current	At ambient temperature & humidity Testing time:5 minutes (under full rated current)	MIP product surface temp: below room temperature plus 40°C

■ General Technical Data

Operating temperature range : - 40° C ~ + 85° C Storage Condition : Less than 40° C and 70° RH

Storage Time : 12 months Max. Soldering method : Reflow

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